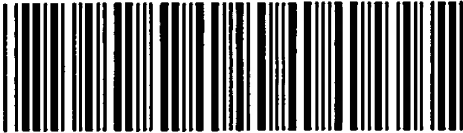


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/065,668	SPOHN ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Cris L. Rodriguez	3763	

SEARCHED			
Class	Subclass	Date	Examiner
UPDATED	SEARCH	8/26/2005	<i>CLR</i> CLR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST-UPDATED SEARCH	8/26/2005	<i>CLR</i> CLR